

Search Notes

Application/Control No.

10/695,379

Examiner

B. Chen

Applicant(s)/Patent under
Reexamination

XIAO ET AL.

Art Unit

1762

SEARCHED

| Class | Subclass | Date | Examiner |
|---------|----------|-----------|----------|
| updated | previous | 5/23/2006 | BC |
| 427 | 255.29 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 427 | 255.29 | 5/23/2006 | BC |
| | 255.393 | | |
| | 255.394 | | |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| east | 5/23/2006 | BC |
| stic | 11/23/2005 | bc |
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